

REMARKS

Reconsideration of the application is respectfully requested in view of the Applicant's remarks. The Office Action has rejected claims 2, 6, and 8-13.

Rejections under 35 U.S.C. §103

Claims 2, 6, and 8-13 stand rejected under 35 U.S.C. §103(a) as being unpatentable over Song et al (Song, O; Menon, P. R.; Parallel pattern fault simulation based on stem faults in combinational circuits, Proceedings International Test Conference, Sept. 10-14, 1990, pp 706-11) [hereinafter referred to as "Song"] and in view of U.S. Patent No. 6205567 to Maruyama ("Maruyama"). Applicant respectfully traverses the rejection. In accordance with M.P.E.P. § 2142, the Examiner bears the initial burden of establishing a *prima facie* case of obviousness. "To establish a *prima facie* case of obviousness, three basic criteria must be met." (M.P.E.P. § 2143.) First, some suggestion or motivation in the prior art references or in the knowledge of one of ordinary skill in the relevant art must exist to modify or combine the references. Second, if the references are combined, a reasonable expectation of success must be shown. Then, finally, all of the claim limitations must be taught or suggested by one reference or a combination of references. To establish a *prima facie* case of obviousness based on a single reference that does not teach all the elements of a claim, the Examiner must provide a rationale for modifying the teachings of the reference. See *In re Kotzab*, 55 U.S.P.Q.2d 1313, 1317 (Fed. Cir. 2000), citing, *B.F. Goodrich Co. v. Aircraft Breaking Sys. Corp.*, 72 F.3d 1577, 1582, 37 U.S.P.Q.2d 1314, 1318 (Fed. Cir.1996).

Song discloses a method for improving the speed of fault simulation of combinational circuits by performing parallel pattern single fault simulation (PPSFP) wherein a number of test

patterns are processed simultaneously based on the word size of the host machine being used to perform the fault simulation. Paragraph 1, Col. 2, page 706. In addition, Song discloses a "method for reducing the expense of backtracing by identifying lines where backtracing may be stopped." Abstract, Col. 1, page 706.

Applicant initially notes that Song does not disclose performing a good machine simulation on the IC with the test to obtain values of each internal node of the IC. The Examiner asserts that "Song teaches True value simulation for determining fault-free values on all lines of the circuit," and cites to the "the last few line in column 2 of page 707 of Song" to support his assertion. The cited part of Song discloses:

For every set of test patterns,
 Perform true-value simulation.
For every active (i.e. undropped) FFR,
 Backtrace from its stem (PO) upto FOB's or PI's

The cited portion of Song discloses performing backtracing in active FFRs (Fanout-Free Regions). *See* definition of FFR, Paragraph 2, Col. 1, page 706. The portion of Song cited by the Examiner does not disclose determining the fault-free values on all lines of the circuit. The Applicant is unable to find any disclosure in the cited portion of Song for performing a good machine simulation on the IC with the test to obtain values of each internal node of the IC.

In addition, Song does not teach backtracing "in a single detection pass," as is required by claims 2, 8, 9, and 10. Instead Song requires that two separate backtracing steps be performed as part of the PPST algorithm. The algorithm disclosed in Song is replicated below:

For every set of test patterns,
 Perform true-value simulation.
 For every active (i.e. undropped) FFR,
 Backtrace from its stem (PO) upto FOB's or PI's
 Propagate the stem fault to a PO, if necessary
 If any stem fault is detected
 Backtrace from the stem, collecting detection information
 If all faults in the FFR have been detected
 Drop the FFR
 End
 [Col. 2, Page 707 – Col. 1, Page 708, emphasis added].

Song discloses the performance of two separate backtracing steps, such that "[t]he set of faults detected by a set of test patterns is determined by a second backtracing inside FFR's."

Paragraph 4, Col. 1, Page 708. Song discloses the performance of a first and second backtracing step (Paragraph 1, Col. 2, Page 708), and is therefore different from the backtracing performed in a single detection pass recited in claims 2, 8, 9, and 10.

Finally, Applicant notes that Song does not disclose backtracing in a single detection pass *through memory elements*. Song only discloses performing the disclosed backtracing for combinational logic. Applicant respectfully submits that Song contains no teachings relating to backtracing through memory elements. That this is the case is demonstrated by the fact that the Office Action made no attempt to show where Song discloses such a feature.

The Examiner asserts that Maruyama "teaches use of a good machine simulation on the IC having logic gates and memory elements." Page 4, Office Action mailed April 10, 2006. The Applicant cannot find any disclosure in Maruyama of either "performing a good machine simulation on the IC to values of each internal node of the IC," or of performing such a good machine simulation on an IC having memory elements. First, Maruyama only discloses the use of true-value simulation to determine whether there is "a difference between the propagated fault and the result of the true-value simulation" at an observation point. Maruyama, Col. 12, lines

18-24. Second, Maruyama defines an activation path *between* circuit branch points, which ultimately end at either memory elements, circuit inputs, or circuit outputs. Maruyama does not try to identify faults across memories in a single detection pass. Maruyama, Col. 12, lines 31-40.

Based on the forgoing, Applicant respectfully submits that neither Song nor Maruyama either alone or in combination, teach or suggest any of the limitations discussed above, and therefore, claims 2, 8, 9, and 10 are allowable. Claim 6 depends from claim 2, claim 11 depends from claim 8, and claims 12-13 depend either directly or indirectly from claim 9, and are therefore allowable for at least the same reasons.

Applicant would also like to note that the Attorney Docket No. was changed when the current attorney took over prosecution of this matter. Applicant requests that the Patent Office change their records to reflect this new reference number which is 700693-4011.

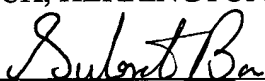
Conclusion

In view of the foregoing, Applicant respectfully submits that this application is in condition for allowance, which is respectfully requested. A Notice of Allowance is earnestly solicited at the earliest possible date. If the Examiner believes that a telephone conference would be useful in moving the application forward to allowance, the Examiner is encouraged to contact the undersigned at (650) 614-7669. If there are any additional fees required, please charge Deposit Account No. 15-0665.

Respectfully submitted,

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